

	Specifica	tion		Ap	prova	al
	Custom	er:深圳臺		_	_	
	TAI-TECH P/N:	HPC5040	NF-Seri	es		
	CUSTOMER P/N:					
	DESCRIPTION:					
	QUANTITY:		pcs	-		
	REMARK:					
	Cu	ustomer Approv	al Feedba	ack		
	西北臺慶科技股份有限公司 TAI-TECH Advanced Electronics Co., Ltd <u>Headquarter:</u> NO.1 YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-ME TAO-YUAN HSIEN, TAIWAN, R.O.C. TEL: +886-3-4641148 FAX: +886-3-4643565 http://www.tai-tech.com.tw E-mail: sales@tai-tech.com.tw	<u> </u> 1,		<u> </u>		
	東莞臺慶精密電子有限公司		Sales D	ep.		
	DONGGUAN TAI-TECH ADVANCED ELECTRONICS CO JITIGANG MANAGEMENT DISTRICT, HUANGJIANG, DONGGUAI GUANGDONG, CHINA		APPR	OVED	CHECKED	
	TEL: +86-769-3365488 FAX: +86-769-3366896 E-mail: sales@tai-tech.net <u>Office:</u> 金亨國際有限公司 KAMHENG INTERNATIONAL LIMITED TEL: +86-852-25772033 FAX: +86-852-28817778			寺涵 I Tseng	曾詩涵 Angela Tseng	
	臺慶精密電子(昆山)有限公司 TAI-TECH ADVANCED ELECTRONICS(KUNSHAN) CO. SHINWHA ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SH JIANG-SU, CHINA		R&D Ce	enter		
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-	慶邦電子元器件(泗洪)有限公司 TAIPAQ ELECTRONICS (SIHONG) CO., LTD JIN SHA JIANG ROAD, CONOMIC DEVELOPMENT ZONE SIHON JIANGSU, CHINA. TEL: +86-527-88601191 FAX: +86-527-88601190 E-mail: sales@taipaq.cn	IG,				

SMD Power Inductor

HPC5040NF-Series

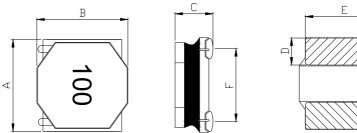
	ECN HISTORY LIST									
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN					
1.0	16/03/25	新發行	楊祥忠	詹偉特	何秦芝					
備										
注										

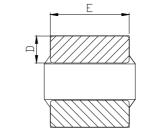
SMD Power Inductor

1. Features

- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

2. Dimension

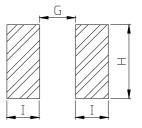




Halogen-free Pb-free

HPC5040NF-Series

Recommended Land pattern

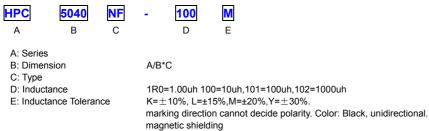


Series	Inductance	A(mm)	B(mm)	C(mm)	D(mm)	E (mm)	F(mm)
HPC5040NF	≪10 uH	4.95±0.2	4.95±0.2	3.9±0.2	1.3±0.3	4.2±0.2	3.7ref
	>10 uH			3.8±0.2	1.5±0.5		

G(mm)	H(mm)	l(mm)
2.1	4.2	1.5
Note · Recor	nmend solde	r naste

thickness at 0.12mm and above

3. Part Numbering



4. Specification

		Tolerance				Rated		
Part Number	Inductance L0 (uH)					Temperature	Saturation	DCR (mΩ) @25℃
	@ 0 A	к	L	м	Y	current I rms (A)	current I sat (A)	±20%.
HPC5040NF-1R0	1.00	1	1	±20%	±30%	5.00	7.50	12
HPC5040NF-1R5	1.50	1	1	±20%	±30%	4.50	6.50	15
HPC5040NF-2R2	2.20	1	1	±20%	±30%	3.80	5.70	21
HPC5040NF-3R3	3.30	1	1	±20%	±30%	3.50	4.40	24
HPC5040NF-4R7	4.70	1	1	±20%	±30%	3.20	3.90	32
HPC5040NF-6R8	6.80	1	1	±20%	±30%	2.50	3.30	43
HPC5040NF-100	10.0	1	1	±20%	±30%	2.20	2.52	56
HPC5040NF-150	15.0	1	±15%	±20%	±30%	1.80	2.00	80
HPC5040NF-220	22.0	1	±15%	±20%	±30%	1.50	1.62	123
HPC5040NF-330	33.0	1	±15%	±20%	±30%	1.20	1.30	180
HPC5040NF-470	47.0	±10%	±15%	±20%	±30%	1.00	1.10	270
HPC5040NF-680	68.0	±10%	±15%	±20%	±30%	0.80	0.90	400
HPC5040NF-101	100	±10%	±15%	±20%	±30%	0.72	0.75	560

Note:

1. All test data referenced to 25° C ambient , Ls:100KHz/1V.

2. Testing Instrument : HP4284A,CH11025,CH3302,CH1320 ,CH1320S LCR METER / Rdc:CH502BC MICRO OHMMETER.

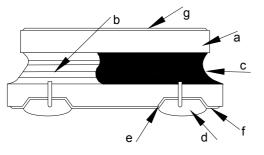
3. Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40°C (keep 1min.).

4. Saturation Current (Isat) will cause L0 to drop 30% typical. (keep quickly).

5. The part temperature (ambient + temp rise) should not exceed 125 °C under worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.

6. Special inquiries besides the above common used types can be met on your requirement.

5. Material List



NO	Items	Materials
а	Core	Ferrite Core
b	Wire	Copper Wire
С	Glue	Magnetic Resin
d	Solder	Lead free-Sn Cu
е	Adhesive	Ероху
f	Copper foil	Pure Copper
g	ink	Halogen-free ketone

6. Reliability and Test Condition

ltem	Performance	Test Condition
Operating temperature	-40~+125°C (Including self - temperature rise)	
Storage temperature	110~+40℃ ,50~60%RH (Product without taping) 240~+125℃(on board)	
Electrical Performance Te	est	
Inductance	Refer to standard electrical characteristics list.	HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.
DCR		CH16502,Agilent33420A Micro-Ohm Meter.
Saturation Current (Isat)	\triangle L30% typical.	Saturation DC Current (Isat) will cause L0 to drop \triangle L(%)(keep quickly).
Heat Rated Current (Irms)	Approximately △T40℃	Heat Rated Current (Irms) will cause the coil temperature rise △T(ℂ) without core loss. 1.Applied the allowed DC current(keep 1 min.). 2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C(Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity : 85±2 _% R.H, Temperature : 85°C±2°C
	_	Duration : 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow
Moisture Resistance	Appearance : No damage. Inductance : within±10% of initial value Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Profiles 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65±2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs,keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.
Thermal shock		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step1 : -40±2°C 30±5min Step2 : 25±2°C ≦0.5min Step3 : 125±2°C 30±5min Number of cycles : 500 Measured at room temperature after placing for 24±2 hrs
Vibration		Oscillation Frequency: 10 ~ 2K ~ 10Hz for 20 minutes Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations)。

TAI-TECH

Item	Performance	Test Condition					
Shock	Appearance : No damage. Inductance : within±10% of initial value Q : Shall not exceed the specification value.	Type SMD Lead	Peak value (g's) 1500 100	Normal duration (D) (ms) 0.5 6	Wave form Half-sine Half-sine	Velocity change (Vi)ft/sec 15.4 12.3	
Bending	RDC : within ±15% of initial value and shall not exceed the specification value	Shall be mounted on a FR4 substrate of the following dimensions: >=0805:40x100x1.2mm <0805:40x100x0.8mm Bending depth: >=0805:1.2mm <0805:0.8mm duration of 10 sec.					
Solderability	More than 95% of the terminal electrode should be covered with solder。	Solder Tempe Flux fo Dip tin	erature: 245 or lead free: ne: 4±1sec。	Ag3% Cu0.5% ≟5℃。 Rosin. 9.5%。			
Resistance to Soldering Heat		Te (°C) ±5(solder	Time(s)	Temperature amp/immers and emersion 25mm/s ±6 n	sion n rate	
Terminal Strength	Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	times. Reflow With t be tes (>080 tested applied gradua	Profiles ted, apply a 5:1kg , <=(. This force d for 60 +1 ally as not to	C J-STD-020D ent mounted o force 0805:0.5kg)to shall be seconds. Also	Classification n a PCB wi the side of p the force :	eflow for 2 h th the device to a device being shall be applied	
		11	DU		press tool	wide	

Note : When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition.

7. Soldering and Mounting

(1) Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

(2) Solder re-flow:

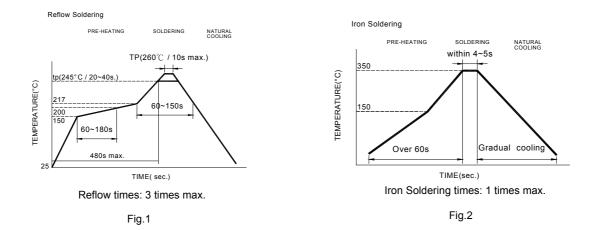
Recommended temperature profiles for re-flow soldering in Figure 1.

(3) Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

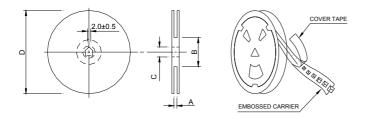
- 355°C tip temperature (max) 1.0mm tip diameter (max)
 - ax)

Use a 20 watt soldering iron with tip diameter of 1.0mm
Limit soldering time to 4~5sec.



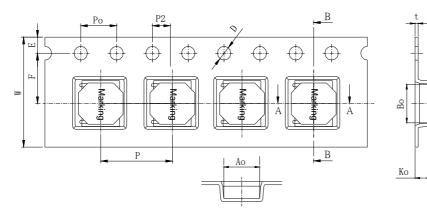
8. Packaging Information

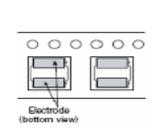
(1) Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)	
13"x12mm	12.4+2/-0	80±2.0	13.5±0.5	330±3.0	

(2) Tape Dimension



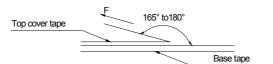


Series	Size	Bo(mm)	Ao(mm)	Ko(mm)	P(mm)	w(mm)	t(mm)	E(mm)	F(mm)	D(mm)	Po(mm)	P2(mm)
HPC	5040	5.4±0.1	5.4±0.1	4.3±0.1	8.0±0.1	12±0.3	0.4±0.1	1.75±0.1	7.5±0.1	1.5±0.1	4.0±0.1	2.00±0.1

(3) Packaging Quantity

HPC	5040
Reel	1500
Inner box	3000
Carton	12000

(4) Tearing Off Force



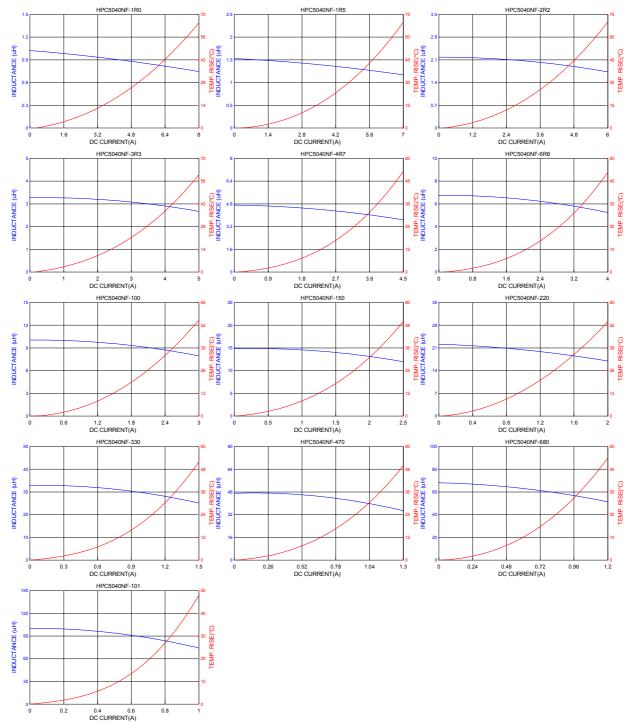
The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions (referenced ANSI/EIA-481-C-2003 of 4.11 standards).

Room Temp.	Room Humidity	Room atm	Tearing Speed		
(℃)	(%)	(hPa)	mm/min		
5~35	45~85	860~1060			

Application Notice

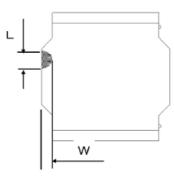
- Storage Conditions(component level)
 To maintain the solderability of terminal electrodes:
 - 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40 $^\circ\!\!\mathbb{C}$ and 60% RH.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
 - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

9. Typical Performance Curves



Core chipping

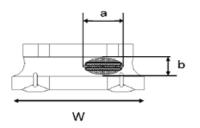
The appearance standard of the chipping size on top side, and bottom side ferrite core is listed below.



L	w		
0.8mm Max.	0.8mm Max.		

Void appearance tolerance Limit

Size of voids occurring to coating resin is specified below.

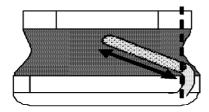


Exposed wire tolerance limit of coating resin part on product side. Size of exposed wire occurring to coating resin is specified below. 1. Width direction (dimension a): Acceptable when $a \leq w/2$.

- 2. Length direction (dimension b): Dimension b is not specified. 3. The total area of exposed wire occurring to each sides is
 - not greater than 50% of coating resin area, and is acceptable.

External appearance criterion for exposed wire

Exposed end of the winding wire at the secondary side should be 3mm and below.



Electrode appearance criterion for exposed wire

Visual check on core surface with no crack means pass. W Conforming Only top side of wire is exposed. (regardless of whole tope side of wire exposed) Less than 1/2 of joint side length. (More than 1/2 is selected as defect) Wire is soldered insufficiently and less than half of outer diameter is covered with solder. Electrodes with foreign body (dirt) appearance standards w L Foreign materials (dirt) will not affect the coplanarity of PAD, 0.8mm Max 0.8mm Max below the example of foreign materials (dirt) quantity ≤2PCS on single PAD.

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dimension range as below.





測試報告 號碼(No.) : CE/2015/B1564 日期(Date) : 2015/11/16 頁數(Page): 1 of 15 **Test Report** 西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD. (臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.) (耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.) (慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.) 桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R.O.C. (江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (江蘇省電市泗洪縣經濟開發區金沙南路-高新技術產業園 / HIGH-TECH INDUSTRIAL DISTRICT, JINSHAJIANG ROAD, SIHONG COUNTY ECONOMIC, SUQIAN CITY, JIANGSU) 以下测試樣品係由申請廠商所提供及確認 (The following sample(s) was/were submitted and identified by/on behalf of the applicant as): SMD POWER INDUCTOR 樣品名稱(Sample Description) HPC(YHC 、 DR) 、 MDC 、 FPC(YPC) 、 FWP(YWP) 、 SPC 、 AHP 、 UHP 、 DFP 、 DHP 、 TLPC 、 樣品型號(Style/Item No.) : TLPH . TLI SERIES -

收件日期(Sample Receiving Date) :

測試期間(Testing Period) : 2015/11/10 TO 2015/11/16 .

测试结果(Test Results) :

請見下一頁 (Please refer to next pages).

2015/11/10

Troy Chang/Manage Signed for and on Dehalf o SGS TAIWAN LTD. Chemical Laboratory - Taipei

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SGS Taiwan Ltd. 台灣檢驗科技股份有限公司 25, Wu Chyuan 7th Road, New Taipel Industrial Park, Wu Ku District, Naw Taipei City, Taiwan 所北市立股區新北產業團區近得上路25號



測試報告 Test Report ^{號碼(Nc}

號碼(No.): CE/2015/B1564

日期(Date): 2015/11/16

頁數(Page): 2 of 15

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.) (耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.) (慶邦電子元器件 (泗洪) 有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.) 桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R.O.C. (江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA)

(江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (江蘇省宿還市泗洪縣經濟開發區金沙南路-高新技術產業園 / HIGH-TECH INDUSTRIAL DISTRICT, JINSHAJIANG ROAD, SIHONG COUNTY ECONOMIC, SUQIAN CITY, JIANGSU)

测试結果(Test Results)

測試部位(PART NAME)No.1 : 整體混測(MIXED ALL PARTS)

测試項目 (Test Items)	單位 (Unit)	测試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鐍 / Cadmium (Cd)	mg/kg	參考IEC 62321-5: 2013方法, 以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-5: 2013 and performed by ICP-AES.	2	n. d.
鉛 / Lead (Pb)	mg/kg	参考IEC 62321-5: 2013方法,以感應耦合 電漿原子發射光譜儀檢測. / ₩ith reference to IEC 62321-5: 2013 and performed by ICP-AES.	2	n. d.
汞 / Mercury (Hg)	mg/kg	參考IEC 62321-4: 2013方法, 以感應耦合 電漿原子發射光譜儀檢測. / With reference to IEC 62321-4: 2013 and performed by ICP-AES.	2	n. d.
六價鉻 / Hexavalent Chromium Cr(VI)	mg/kg	參考IEC 62321: 2008方法,以UV-VIS檢測. / With reference to IEC 62321: 2008 and performed by UV-VIS.	2	n. d.
六溴環十二烷及所有主要被辨別出的異構物 / Hexabromocyclododecane (HBCDD) and all major diastereoisomers identified (α - HBCDD, β - HBCDD, γ - HBCDD) (CAS No.: 25637-99-4 and 3194-55-6 (134237-51-7, 134237-50-6, 134237-52-8))	mg/kg	參考IEC 62321: 2008方法, 以魚相層析/質 譜儀檢測. / With reference to IEC 62321: 2008 method. Analysis was performed by GC/MS.	5	n. d.

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SGS Taiwan Ltd. 台湾検验科技股份有限公司 🕴 25, Wu Chyuan 7th Road, New Taipei Industrial Park, Wu Xu District, New Taipei City, Taiwan 新北市石級區新北產業園區五權上路25號

Member of the SGS Group



测試報告 號碼(No.): CE/2015/B1564 **Test Report**

西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

(臺慶精密電子(昆山)有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.)

(耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

(慶邦電子元器件(泗洪)有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.)

桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R.O.C. (江蘇省昆山市篷朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (江蘇省宿邊市泗洪縣經濟開發區金沙南路-高新技術產業園 / HIGH-TECH INDUSTRIAL DISTRICT, JINSHAJIANG ROAD, SIHONG COUNTY ECONOMIC, SUQIAN CITY, JIANGSU)

日期(Date): 2015/11/16

测試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
聚氯乙烯 / PVC	**	以紅外光譜分析及焰色法檢測. / Analysis was performed by FTIR and FLAME Test.	_	Negative
多溴聯苯總和 / Sum of PBBs	mg/kg		-	n. d.
一溴聯苯 / Monobromobiphenyl	mg/kg		5	n. d.
二溴聯苯 / Dibromobiphenyl	mg/kg		5	n. d.
三溴聯苯 / Tribromobiphenyl	mg/kg		5	n. d.
四溴聯苯 / Tetrabromobiphenyl	mg/kg		5	n.d.
五溴聯苯 / Pentabromobiphenyl	mg/kg		5	n. d.
六溴聯苯 / Hexabromobiphenyl	mg/kg		5	n. d.
七溴聯苯 / Heptabromobiphenyl	mg/kg		5	n. d.
八溴聯苯 / Octabromobiphenyl	ng/kg		5	n. d.
九溴聯苯 / Nonabromobiphenyl	mg/kg		5	n. d.
十溴聯苯 / Decabromobiphenyl	mg/kg	參考IEC 62321-6: 2015方法,以氣相層析/	5	n. d.
多溴聯苯醚總和 / Sum of PBDEs	mg/kg	質譜儀檢測. / With reference to IEC 62321-6: 2015 and performed by GC/MS.	-	n. d.
一溴聯苯醚 / Monobromodiphenyl ether	mg/kg	62321-6: 2013 and performed by 607 ms.	5	n. d.
二溴聯苯醚 / Dibromodiphenyl ether	mg/kg		5	n. d.
三溴聯苯醚 / Tribromodiphenyl ether	mg/kg		5	n. d.
四溴聯苯醚 / Tetrabromodiphenyl ether	mg/kg		5	n. d.
五溴聯苯醚 / Pentabromodiphenyl ether	mg/kg		5	n.d.
六溴聯苯醚 / Hexabromodiphenyl ether	mg/kg .		5	n. d.
七溴聯苯醚 / Heptabromodiphenyl ether	mg/kg]	5	n. d.
八溴聯苯醚 / Octabromodiphenyl ether	mg/kg	1	5	n. d.
九溴聯苯醚 / Nonabromodiphenyl ether	ng/kg]	5	n. d.
十溴聯苯醚 / Decabromodiphenyl ether	mg/kg		5	• n.d.

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限值 (MDL)	結果 (Result) No.1
绨 / Antimony (Sb)	mg/kg	参考US EPA 3052方法,以感應耦合電漿原 子發射光譜儀檢測. / With reference to US EPA Method 3052. Analysis was performed by ICP-AES.	2	n. d.
鈹 / Beryllium (Be)	mg/kg	参考US EPA 3052方法,以感應耦合電漿原 子發射光譜儀檢測. / With reference to US EPA Method 3052. Analysis was performed by ICP-AES.	2	n. d.
全氣辛烷磺酸 / Perfluorooctane sulfonates (PFOS-Acid, Metal Salt, Amide)	mg/kg	參考US EPA 3550C: 2007方法, 以液相層析 /質譜儀檢測. / With reference to US EPA 3550C: 2007. Analysis was performed by LC/MS.	10	n. d.
全氣辛酸 / PFOA (CAS No.: 335-67-1)	mg/kg	参考US EPA 3550C: 2007方法, 以液相層析 /質譜儀檢測. / With reference to US EPA 3550C: 2007. Analysis was performed by LC/MS.	10	n. d.
鹵素 / Halogen				
鹵素 (氟) / Halogen-Fluorine (F) (CAS No.: 14762-94-8)	mg/kg		50	n.d.
鹵素 (氣) / Halogen-Chlorine (Cl) (CAS No.: 22537-15-1)	mg/kg	参考BS EN 14582:2007,以離子層祈儀分 析./ With reference to BS EN	50	n.d.
鹵素 (溴) / Halogen-Bromine (Br) (CAS No.: 10097-32-2)	mg/kg	14582:2007. Analysis was performed by IC.	50	n.d.
鹵素 (碘) / Halogen-Iodine (I) (CAS No.: 14362-44-8)	mg/kg]	50	n. d.

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測試報告 Test Report^號

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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD.

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測試項目 (Test Items)	單位 (Unit)	測試方法 (Method)	方法偵測 極限値 (MDL)	結果 (Result) No.1
鄰苯二甲酸丁苯甲酯 / BBP (Butyl Benzyl phthalate) (CAS No.: 85-68-7)	mg/kg		50	n. d.
鄰苯二甲酸二丁酯 / DBP (Dibutyl phthalate) (CAS No.: 84-74-2)	mg/kg		50	n. d.
鄰苯二甲酸二 (2-乙基己基)酯 / DEHP (Di- (2-ethylhexyl) phthalate) (CAS No.: 117-81-7)	mg/kg		50	n. d.
鄰苯二甲酸二異丁酯 / DIBP(Di- isobutyl phthalate)(CAS No.: 84-69- 5)	mg/kg	參考IEC 62321-8 (111/321/CD),以氣相層 析儀/質譜儀檢測之. / With reference to	50	n.d.
鄰苯二甲酸二異癸酯 / DIDP (Di- isodecyl phthalate) (CAS No.: 26761- 40-0; 68515-49-1)	mg/kg	IEC 62321-8 (111/321/CD). Analysis was performed by GC/MS.	50	n. d.
鄰苯二甲酸二異壬酯 / DINP (Di- isononyl phthalate) (CAS No.: 28553- 12-0; 68515-48-0)	mg/kg		50	n, d.
鄰苯二甲酸二正辛酯 / DNOP (Di-n- octyl phthalate) (CAS No.: 117-84-0)	mg/kg		50	n. d.
鄰苯二甲酸二正己酯 / DNHP (Di-n- hexyl phthalate) (CAS No.: 84-75-3)	mg/kg		50	n. d.

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備註(Note):

- 1. mg/kg = ppm; 0.1wt% = 1000ppm
- 2. n.d. = Not Detected (未檢出)
- 3. MDL = Method Detection Limit (方法偵測極限值)
- 4. "-" = Not Regulated (無規格值)
- 5. **= Qualitative analysis (No Unit) 定性分析(無單位)
- 6. Negative = Undetectable 陰性(未偵測到); Positive = Detectable 陽性(已偵測到)
- 7. 樣品的測試是基於申請人要求混合測試,報告中的混合測試結果不代表其中個別單一材質的含量. (The samples was/were analyzed on behalf of the applicant as mixing sample in one testing. The above results was/were only given as the informality value.)

PFOS參考資訊(Reference Information): 持久性有機污染物 POPs - (EU) 757/2010

PFOS濃度在物質或製備中不得超過0.001%(10ppm),在半成品、成品或零部件中不得超過0.1%(1000ppm),在紡織品或塗 層材料中不得超過1µg/m²。

(Outlawing PFOS as substances or preparations in concentrations above 0.001% (10ppm), in semi-finished products or articles or parts at a level above 0.1%(1000ppm), in textiles or other coated materials above $l_{\mu}g/m^2$.)

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測試報告 Test Report ^{號碼(No.):C}

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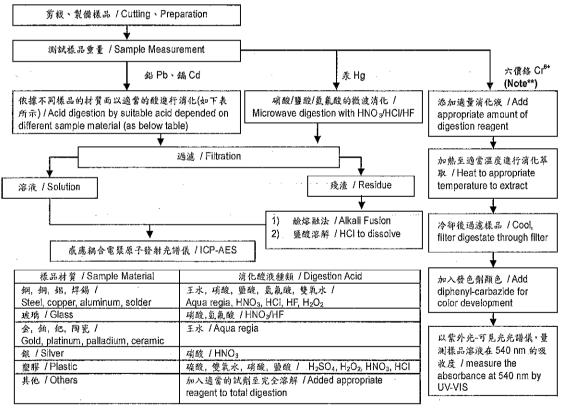
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西北臺慶科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS CO., LTD. (權續科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.) (權續科技股份有限公司 / TAI-TECH ADVANCED ELECTRONICS (KUN-SHAN) CO. LTD.) (慶邦電子元器件 (泗洪) 有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.) (慶邦電子元器件 (泗洪) 有限公司 / TAIPAQ ELECTRONICS (SI-HONG) CO., LTD.) 桃園市楊梅區幼獅工業區幼四路1號 / NO. 1, YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN CITY, TAIWAN, R.O.C. (江蘇省昆山市蓬朗昆嘉高科技工業區郭澤路 / GUO-ZE ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA) (桃園市中壢區中壢工業區長春六路15號 / NO. 15, CHANGCHUN 6TH RD., JHONGLI CITY, TAOYUAN COUNTY 320, TAIWAN) (江蘇省宿還市泗洪縣經濟開發區金沙南路-高新技術產業園 / HIGH-TECH INDUSTRIAL DISTRICT, JINSHAJIANG ROAD, SIHONG COUNTY ECONOMIC, SUQIAN CITY, JIANGSU)

 根據以下的流程圖之條件,樣品已完全溶解。(六價鋒測試方法除外) / These samples were dissolved totally by pre-conditioning method according to below flow chart. (Cr⁸⁺ test method excluded)

- 2) 测试人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 3) 测試負責人:張啟與 / Name of the person in charge of measurement: Troy Chang



Note** (For JEC 62321)

- (1) 針對非金屬材料加入鹼性消化液,加熱至 90~95℃萃取. / For non-metallic material, add alkaline digestion reagent and heat to 90~95℃.
- (2) 針對金屬材料加入純水,加熱至沸腾萃取. / For metallic material, add pure water and heat to boiling.

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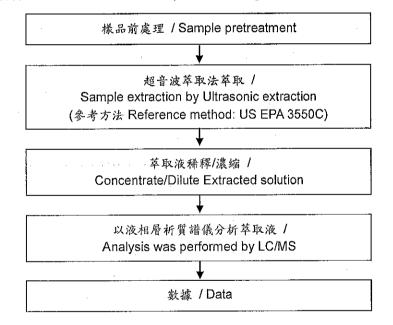
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全氟辛酸/全氟辛烷磺酸分析流程圖 / PFOA/PFOS analytical flow chart

■ 测試人員: 翁賜彬 / Name of the person who made measurement: Roman Wong

■ 測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang



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測試報告 ^{號碼(No.)}: CE/2015/B1564 日期(Date): 2015/11/16 **Test Report**

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(耀鑽科技股份有限公司 / YOSONIC TECHNOLOGY CO., LTD.)

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- 根據以下的流程圖之條件,樣品已完全溶解。 / These samples were dissolved totally by pre-conditioning method according to below flow chart.
- 测試人員:楊登偉 / Name of the person who made measurement: Climbgreat Yang
- 测試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang

元素以 ICP-AES 分析的消化流程圖 (Flow Chart of digestion for the elements analysis performed by ICP-AES) 剪裁、製備樣品 / Cutting、Preparation T 測試樣品重量 / Sample Measurement 依據不同樣品的材質而以適當的酸進行消化(如下表所示)/Acid digestion by suitable acid depended on different sample material (as below table) 過濾 / Filtration T 殘渣 / Residue 溶液 / Solution 1) 鹼熔融法 / Alkali Fusion 2) 鹽酸溶解 / HCI to dissolve 感應耦合電漿原子發射光譜儀 / ICP-AES 王水,硝酸,鹽酸,氫氟酸,雙氧水 / 鋼,銅,鋁,焊錫 / Steel, copper, aluminum, solder Aqua regia, HNO₃, HCl, HF, H₂O₂ 硝酸,氫氟酸 / HNO₃/HF 玻璃 / Glass 金,鉑,鉅,陶瓷 / Gold, platinum, palladium, ceramic 王水 / Aqua regia 硝酸 / HNO3 銀 / Silver 塑膠 / Plastic 硫酸,雙氧水,硝酸,鹽酸 / H2SO4, H2O2, HNO3, HCI 加入適當的試劑至完全溶解 / Added appropriate 其他 / Others reagent to total digestion

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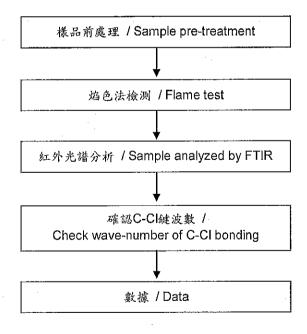
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聚氯乙烯物質判定分析流程圖 1

Analysis flow chart for determination of PVC in material

■ 测試人員:林建宇 / Name of the person who made measurement: Roy Lin

■ 測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang



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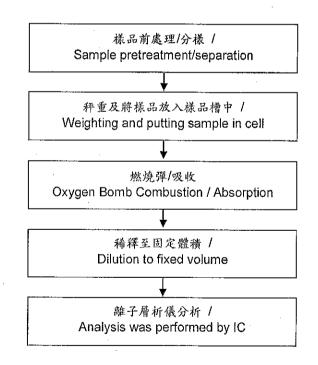
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鹵素分析流程圖 / Analytical flow chart of halogen content

■ 測試人員:陳恩臻 / Name of the person who made measurement: Rita Chen

■ 測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang



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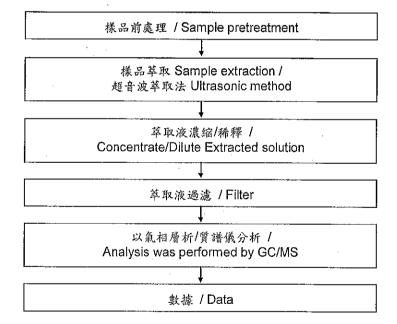
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六溴環十二烷分析流程圖 / HBCDD analytical flow chart

■ 測試人員:翁賜彬 / Name of the person who made measurement: Roman Wong

■ 測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang



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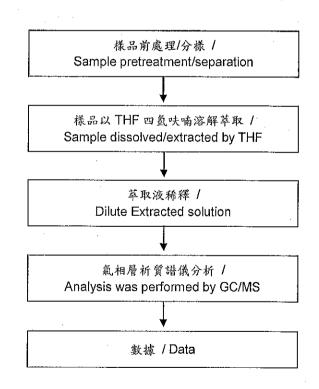
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可塑劑分析流程圖 / Analytical flow chart of phthalate content

测試人員:徐毓明 / Name of the person who made measurement: Andv Shu

測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang

【测试方法/Test method: IEC 62321-8】



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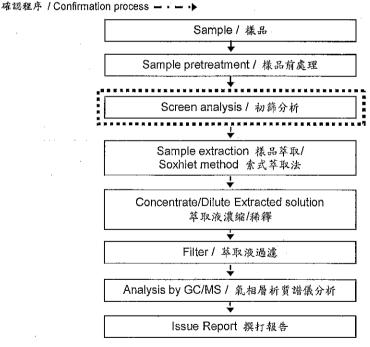
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多溴聯苯/多溴聯苯醚分析流程圖 / PBB/PBDE analytical FLOW CHART

■ 测試人員:翁賜彬 / Name of the person who made measurement: Roman Wong

■ 測試負責人:張啟興 / Name of the person in charge of measurement: Troy Chang

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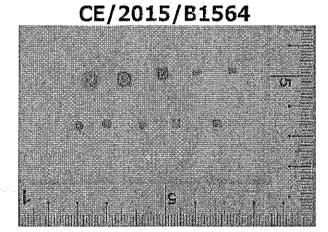
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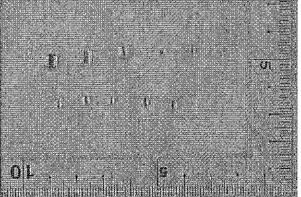
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> * 照片中如有箭頭標示,則表示為實際檢測之樣品/部位. * (The tested sample / part is marked by an arrow if it's shown on the photo.)



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